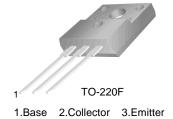


KSC5321F

High Voltage and High Reliability

- High speed Switching
- Wide Safe Operating Area



NPN Triple Diffused Planar Silicon Transistor

Absolute Maximum Ratings $T_C=25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Value	Units
V _{CBO}	Collector-Base Voltage	800	V
V_{CEO}	Collector-Emitter Voltage	500	V
V _{EBO}	Emitter-Base Voltage	7	V
I _C	Collector Current (DC)	5	Α
I _{CP}	*Collector Current (Pulse)	10	Α
I _B	Base Current (DC)	2	Α
I _{BP}	*Base Current (Pulse)	4	Α
P _C	Power Dissipation(Tc=25)	40	W
TJ	Junction Temperature	150	°C
T _{STG}	Storage Temperature	- 55 ~ 150	°C

^{*} Pulse Test: Pulse Width=5ms, Duty Cycle≤10%

Thermal Characteristics $T_C=25$ °C unless otherwise noted

Symbol	Characteristics		Rating	Unit
$R_{\theta jc}$	Thermal Resistance	Junction to Case	3.1	°C/W
$R_{\theta ja}$		Junction to Ambient	62.5	

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$\textbf{Electrical Characteristics} \ \, \textbf{T}_{\text{C}} = 25 \, ^{\circ} \text{C unless otherwise noted}$

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
BV _{CBO}	Collector-Base Breakdown Voltage	$I_{C} = 1 \text{mA}, I_{E} = 0$	800	-	-	V
BV _{CEO}	Collector-Emitter Breakdown Voltage	$I_C = 5mA, I_B = 0$	500	-	-	V
BV _{EBO}	Emitter-Base Breakdown Voltage	$I_{C} = 1 \text{ mA}, I_{C} = 0$	7	-	-	V
I _{CBO}	Collector Cut-off Current	$V_{CB} = 800 V, I_{E} = 0$	-	-	10	μΑ
I _{EBO}	Emitter Cut-off Current	$V_{EB} = 7V, I_{C} = 0$	-	-	10	μΑ
h _{FE1}	DC Current Gain	$V_{CE} = 5V, I_{C} = 0.6A$	15	-	40	
h _{FE2}		$V_{CE} = 5V$, $I_C = 3A$	8	-	-	
V _{CE} (sat)	Collector-Emitter Saturation Voltage	$I_C = 3A, I_B = 0.6A$	-	-	1.0	V
V _{BE} (sat)	Base-Emitter Saturation Voltage	$I_C = 3A, I_B = 0.6A$	-	-	1.5	V
f _T	Current Gain Bandwidth Product	$V_{CE} = 10V, I_{C} = 0.6A$		14	-	MHz
C _{ob}	Output Capacitance	$V_{CB} = 10V, I_{E} = 0, f = 1MHz$	-	65	100	pF
C _{ib}	Input Capacitance	$V_{EB} = 7V, I_{C} = 0, f = 1MHz$	-	1400	2000	pF
t _{ON}	Turn On Time	V _{CC} = 250V, I _C = 1A	-	-	0.5	μs
t _{STG}	Storage Time	$I_{B1} = -I_{B2} = 0.2A$		-	6.5	μs
t _F	Fall Time	$R_L = 250\Omega$	-	-	0.3	μs
t _{ON}	Turn On Time	$V_{CC} = 250V, I_{C} = 4A$	-	-	0.5	μs
t _{STG}	Storage Time	$I_{B1} = 0.8A, I_{B2} = -1.6A$	-	-	3.0	μs
t _F	Fall Time	$R_L = 125\Omega$	-	-	0.3	μs

 $V_{CE} = 5V$

Typical Characteristics

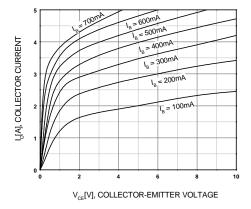


Figure 1. Static Characteristic

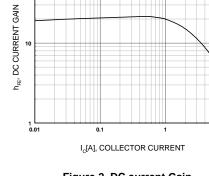


Figure 2. DC current Gain

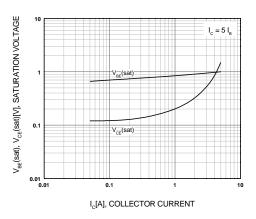


Figure 3. Base-Emitter Saturation Voltage Collector-Emitter Saturation Voltage

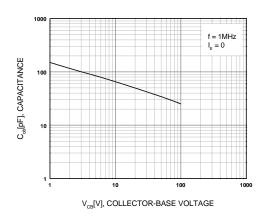


Figure 4. Collector Output Capacitance

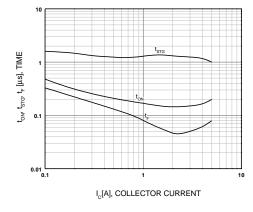


Figure 5. Switching Time

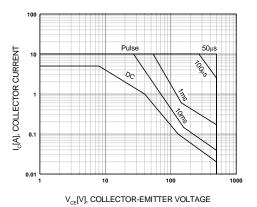


Figure 6. Safe Operating Area

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Typical Characteristics (Continued)

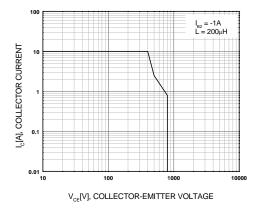


Figure 7. Reverse Bias Safe Operating Area

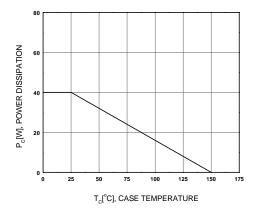


Figure 8. Power Derating

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